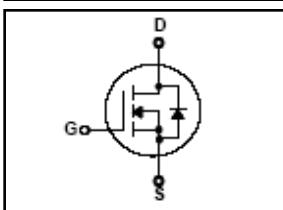


## HCS60R750V 600V N-Channel Super Junction MOSFET

### FEATURES

- Originative New Design
- Superior Avalanche Rugged Technology
- Robust Gate Oxide Technology
- Very Low Intrinsic Capacitances
- Excellent Switching Characteristics
- Unrivalled Gate Charge : 14 nC (Typ.)
- Extended Safe Operating Area
- Lower  $R_{DS(ON)}$  : 0.67 Ω (Typ.) @ $V_{GS}=10V$
- 100% Avalanche Tested

$BV_{DSS} = 600 V$   
 $R_{DS(on)\ typ} = 0.67 \Omega$   
 $I_D = 7 A$



### Absolute Maximum Ratings $T_C=25^\circ C$ unless otherwise specified

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source Voltage	600	V
$I_D$	Drain Current – Continuous ( $T_C = 25^\circ C$ )	7*	A
	Drain Current – Continuous ( $T_C = 100^\circ C$ )	4.4*	A
$I_{DM}$	Drain Current – Pulsed (Note 1)	21*	A
$V_{GS}$	Gate-Source Voltage	$\pm 30$	V
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	90	mJ
$I_{AR}$	Avalanche Current (Note 1)	4	A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	0.5	mJ
$P_D$	Power Dissipation ( $T_C = 25^\circ C$ )	32	W
	- Derate above $25^\circ C$	0.26	W/ $^\circ C$
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150	$^\circ C$
$T_L$	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	$^\circ C$

\* Drain current limited by maximum junction temperature

### Thermal Resistance Characteristics

Symbol	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	3.9	$^\circ C/W$
$R_{\theta JA}$	Junction-to-Ambient	--	60.5	

**Electrical Characteristics**  $T_C=25^\circ\text{C}$  unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
--------	-----------	-----------------	-----	-----	-----	-------

**On Characteristics**

$V_{GS}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \mu\text{A}$	2.5	--	3.5	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}$ , $I_D = 4.4 \text{ A}$	--	0.67	0.75	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 10$ , $I_D = 4.4 \text{ A}$	--	5	--	S

**Off Characteristics**

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}$ , $I_D = 250 \mu\text{A}$	600	--	--	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 600 \text{ V}$ , $V_{GS} = 0 \text{ V}$	--	--	10	$\mu\text{A}$
		$V_{DS} = 480 \text{ V}$ , $T_C = 125^\circ\text{C}$	--	--	100	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 20 \text{ V}$ , $V_{DS} = 0 \text{ V}$	--	--	$\pm 100$	nA

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS} = 50 \text{ V}$ , $V_{GS} = 0 \text{ V}$ , $f = 1.0 \text{ MHz}$	--	710	920	pF
$C_{oss}$	Output Capacitance		--	200	260	pF
$C_{rss}$	Reverse Transfer Capacitance		--	3.5	4.6	pF
$R_g$	Gate Resistance	$V_{GS} = 0 \text{ V}$ , $V_{DS} = 0 \text{ V}$ , $f = 1\text{MHz}$	--	0.5	--	$\Omega$

**Switching Characteristics**

$t_{d(on)}$	Turn-On Time	$V_{DS} = 300 \text{ V}$ , $I_D = 7 \text{ A}$ , $R_G = 25 \Omega$	--	20	50	ns
$t_r$	Turn-On Rise Time		--	25	60	ns
$t_{d(off)}$	Turn-Off Delay Time		--	60	130	ns
$t_f$	Turn-Off Fall Time		--	25	60	ns
$Q_g$	Total Gate Charge	$V_{DS} = 480 \text{ V}$ , $I_D = 7 \text{ A}$ , $V_{GS} = 10 \text{ V}$	--	14	18.5	nC
$Q_{gs}$	Gate-Source Charge		--	4	--	nC
$Q_{gd}$	Gate-Drain Charge		--	5	--	nC

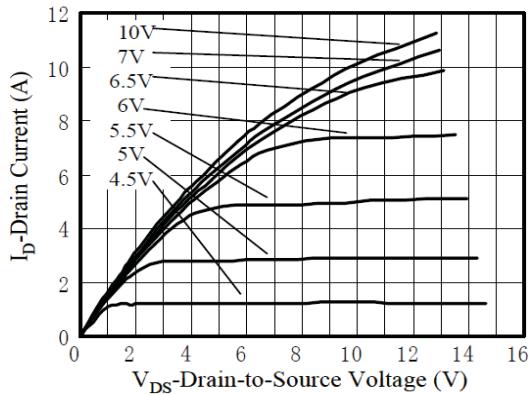
**Source-Drain Diode Maximum Ratings and Characteristics**

$I_S$	Continuous Source-Drain Diode Forward Current	--	--	7	A	
$I_{SM}$	Pulsed Source-Drain Diode Forward Current	--	--	21		
$V_{SD}$	Source-Drain Diode Forward Voltage	$I_S = 7 \text{ A}$ , $V_{GS} = 0 \text{ V}$	--	--	1.2	V
$trr$	Reverse Recovery Time	$I_S = 7 \text{ A}$ , $V_{GS} = 0 \text{ V}$ $dI_F/dt = 100 \text{ A}/\mu\text{s}$	--	300	--	ns
$Qrr$	Reverse Recovery Charge		--	2.4	--	$\mu\text{C}$

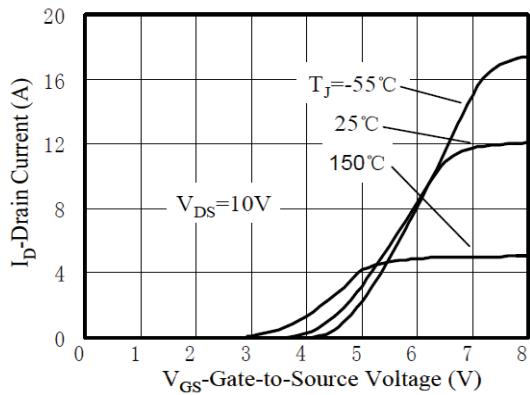
**Notes :**

- Repetitive Rating : Pulse width limited by maximum junction temperature
- $I_{AS}=4\text{A}$ ,  $V_{DD}=50\text{V}$ ,  $R_G=25\Omega$ , Starting  $T_J=25^\circ\text{C}$

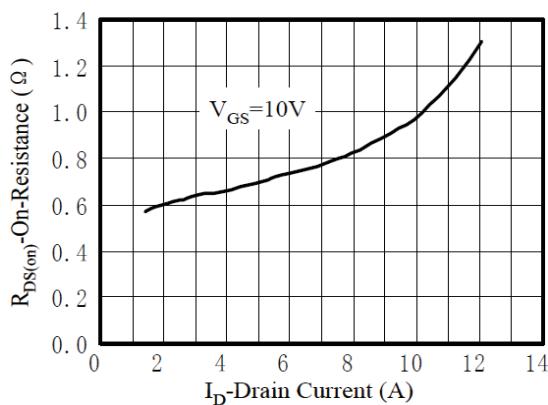
## Typical Characteristics



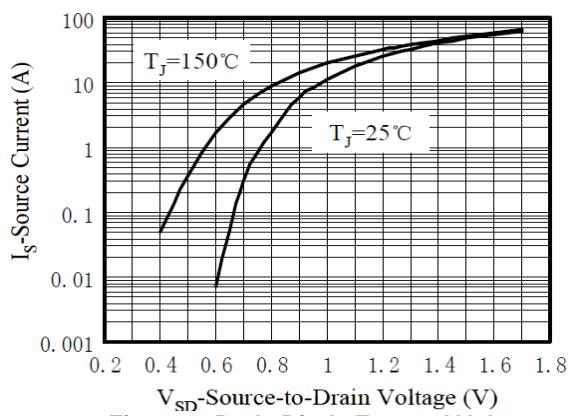
**Figure 1. On Region Characteristics**



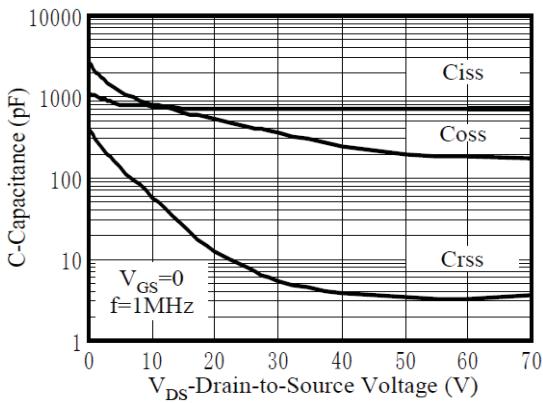
**Figure 2. Transfer Characteristics**



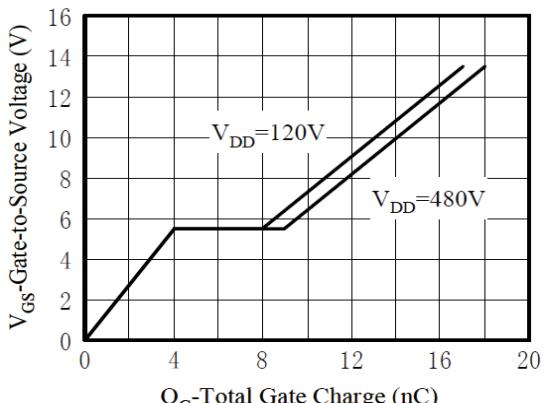
**Figure 3. On Resistance Variation vs. Drain Current and Gate Voltage**



**Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature**



**Figure 5. Capacitance Characteristics**



**Figure 6. Gate Charge Characteristics**

## Typical Characteristics (continued)

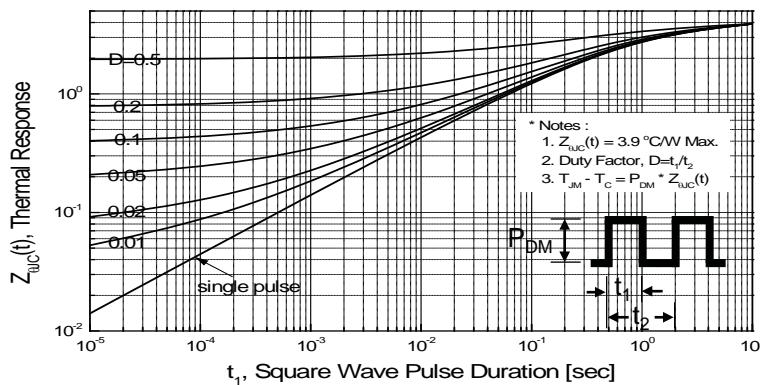
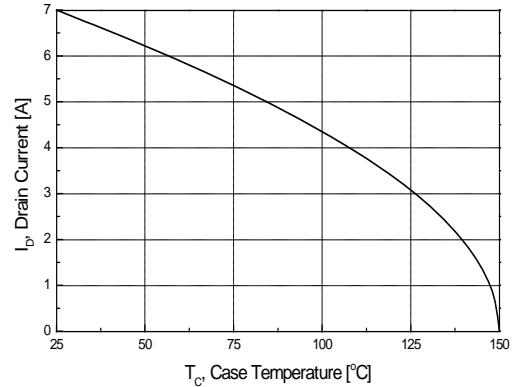
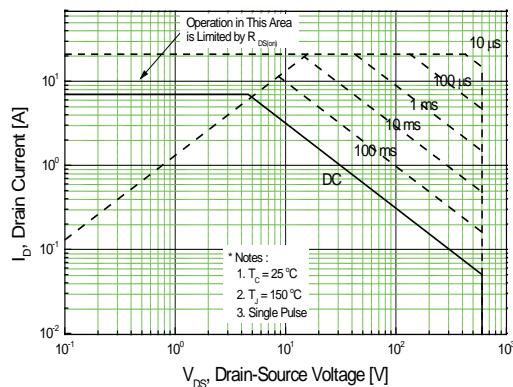
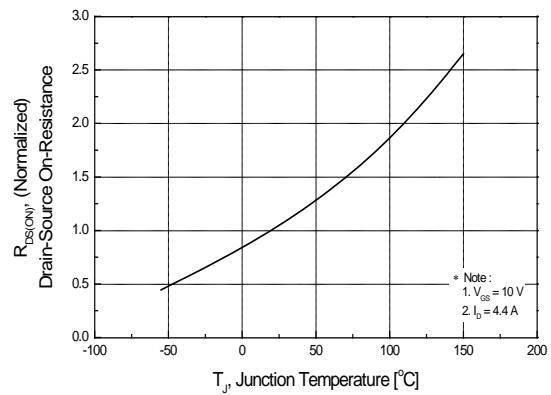
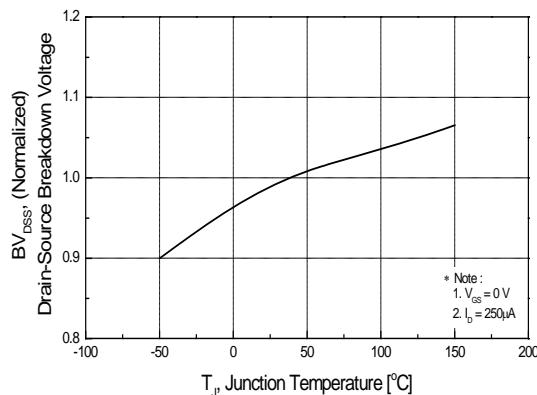


Fig 12. Gate Charge Test Circuit &amp; Waveform

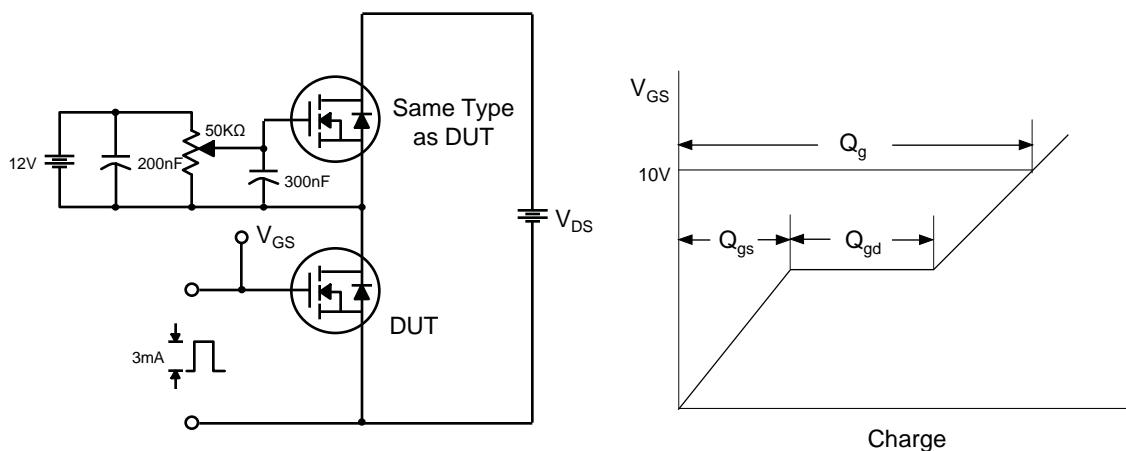


Fig 13. Resistive Switching Test Circuit &amp; Waveforms



Fig 14. Unclamped Inductive Switching Test Circuit &amp; Waveforms

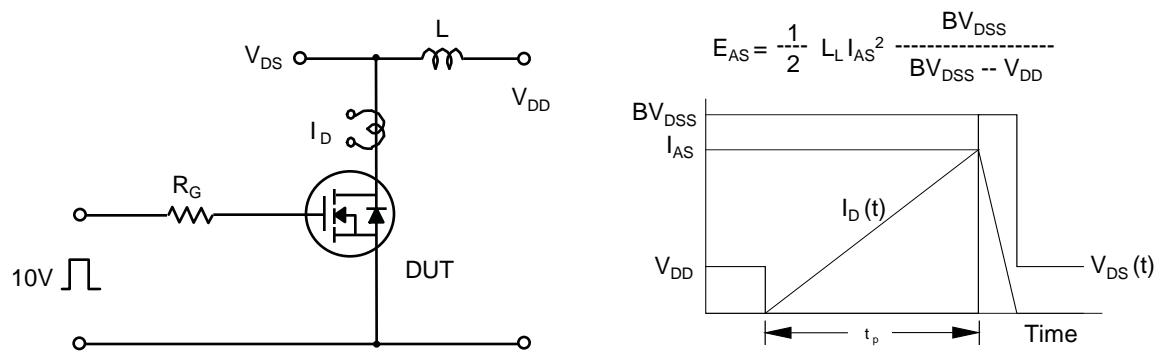
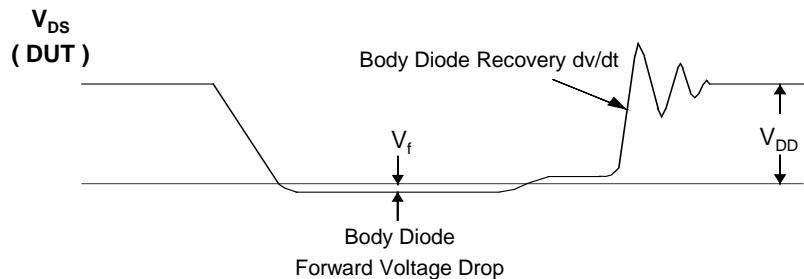
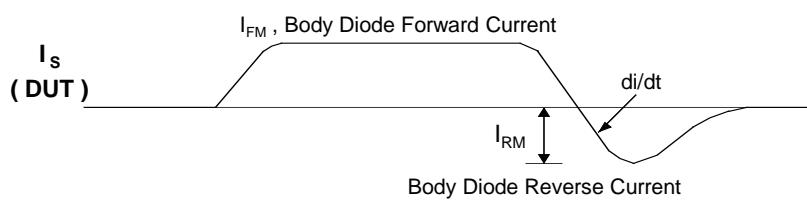
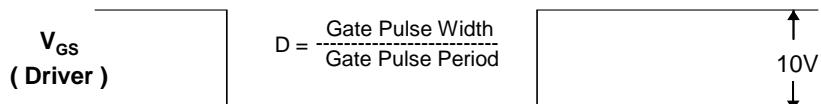


Fig 15. Peak Diode Recovery dv/dt Test Circuit &amp; Waveforms



## Package Dimension

TO-220F

